


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595643	<b>Applicant(s)/Patent Under Reexamination</b>  SAGNE ET AL.
	<b>Examiner</b>  ALLAHYAR KASRAIAN	<b>Art Unit</b>  2617

### SEARCHED

Class	Subclass	Date	Examiner
370	332, 331	11/21/2008	AK
455	436	11/21/2008	AK

### SEARCH NOTES

Search Notes	Date	Examiner
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM TDB (see attached search strategy)	11/21/2008	AK
Inventor name and Assignee search in PALM ExPo and EAST	11/21/2008	AK
(370/331-335.ccls. 455/436-444.ccls.) and (inter near2 frequency) and (inter near2 RAT)	11/21/2008	AK
(370/331-335.ccls. 455/436-444.ccls.) and ((switch\$3 with (frequency channel) with measur\$5) same (decod\$3 encod\$3))	11/21/2008	AK
IEEE Xplore: <a href="http://ieeexplore.ieee.org/Xplore/DynWel.jsp">http://ieeexplore.ieee.org/Xplore/DynWel.jsp</a>	11/21/2008	AK
Google: <a href="http://www.google.com">http://www.google.com</a>	11/21/2008	AK
EPO Data base: <a href="http://ep.espacenet.com">http://ep.espacenet.com</a>	11/21/2008	AK
Updated search	5/25/2009	AK

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/A. K./  
Examiner, Art Unit 2617